

Notice of References Cited	Application/Control No. 09/911,613	Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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	C	US-6,358,759	03-2002	Hirabayashi, Yukiya	438/7
	D	US-6,509,942	01-2003	Tanaka et al.	349/113
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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